

Deductive Fault Simulator

Group 1

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Introduction to Fault Simulation

What is Fault Simulation?

Fault simulation is a process used in VLSI testing to analyze how a digital circuit behaves in the presence of physical defects (faults).

Why is it critical?

- To measure the effectiveness of a set of test vectors.
- This effectiveness is quantified by **Fault Coverage**.
- Fault Coverage = $\frac{\text{Number of Detected Faults}}{\text{Total Number of Faults}} \times 100\%$
- Essential for ensuring the quality and reliability of manufactured chips.

Project Objectives

The primary goal is to develop a robust Deductive Fault Simulator in MATLAB.

- Parse Circuit Netlist: Read and interpret a gate-level Verilog circuit description.
- @ Generate Fault List: Create a collapsed list of single stuck-at faults to eliminate redundancy.
- 3 Process Test Vectors: Read a set of input test patterns from a file.
- Implement Deductive Simulation:
 - Simulate the fault-free circuit for each test vector.
 - Deduce faulty circuit behavior via fault-list propagation.
- 6 Generate Statistics: Produce a detailed fault coverage report.

Core Concept: The Deductive Method

Unlike serial simulation, which tests one fault at a time, the deductive method is a **one-pass** technique for each vector.

The Fault List (L_x)

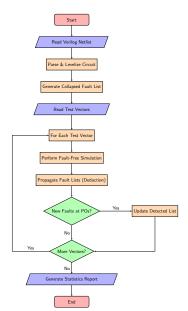
Each signal line x in the circuit has a **fault list** L_x containing all faults that cause x to deviate from its fault-free value.

• These lists are propagated logically rather than through separate simulations.

How it Works:

- Simulate the good (fault-free) circuit once per vector.
- ② For each gate, compute the output fault list (L_{out}) using set operations on input fault lists.
- 3 A fault is detected if it appears in the fault list of any primary output.

Project Flowchart



Parsing & Levelization

Verilog Parsing & Circuit Levelization

- Read a structural Verilog file (.v) and identify primary inputs/outputs, wires, and gates.
- Store circuit data in a containers. Map in MATLAB for efficient lookup.
- **Levelization:** Perform a topological sort to ensure a gate is simulated only after its inputs are evaluated.

Fault List Generation

Collapsed Fault List Generation

- Initially generate all single stuck-at-0 and stuck-at-1 faults.
- Apply Fault Collapsing to remove equivalent faults (e.g., AND gate input SA0 \equiv output SA0).
- This significantly reduces simulation complexity.

Next Steps to be Implemented

Next To Dos

- Reading Test Vectors
- Deductive Fault Simulation
- Statistics Report Generation